

CMOS Digital Integrated Circuits Silicon Monolithic

# 74HC165D

#### 1. Functional Description

• 8-Bit Shift Register (P-IN, S-OUT)

#### 2. General

The 74HC165D is a high speed CMOS 8-BIT PARALLEL/SERIAL-IN, SERIAL-OUT SHIFT REGISTER fabricated with silicon gate C<sup>2</sup>MOS technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

It consists of parallel-in or serial-in, serial-out 8-bit shift register with a gated clock inputs. When the SHIFT/ $\overline{\text{LOAD}}$  input is held high, the serial data input is enabled and the eight frip-frops perform serial shifting with each clock pulse.

When the SHIFT/LOAD input is held low, the parallel data is loaded synchronously into the register at positive going transition of the clock pulse.

The CK-INH input should be shifted high only when the CK input is held high.

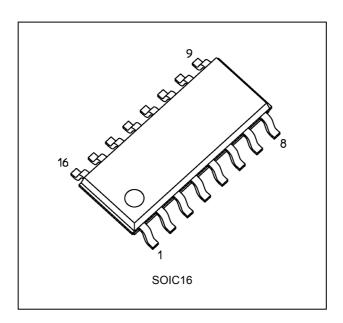
All inputs are equipped with protection circuits against static discharge or transient excess voltage.

#### 3. Features

- (1) Wide operating temperature range:  $T_{opr} = -40$  to 125 °C (Note 1)
- (2) High speed:  $f_{MAX} = 56 \text{ MHz}$  (typ.) at  $V_{CC} = 5 \text{ V}$
- (3) Low power dissipation:  $I_{CC} = 4.0 \,\mu\text{A}$  (max) at  $T_a = 25 \,^{\circ}\text{C}$
- (4) Balanced propagation delays: t<sub>PLH</sub> ≈ t<sub>PHL</sub>
- (5) Wide operating voltage range:  $V_{CC(opr)} = 2.0 \text{ V}$  to 6.0 V

Note 1: Operating Range spec of  $T_{opr}$  = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.

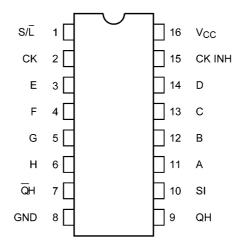
### 4. Packaging



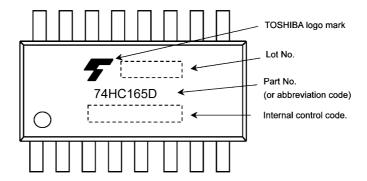
Start of commercial production



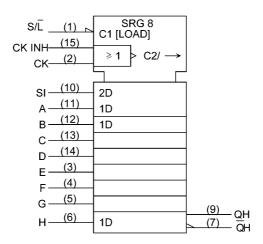
# 5. Pin Assignment



# 6. Marking



# 7. IEC Logic Symbol





#### 8. Truth Table

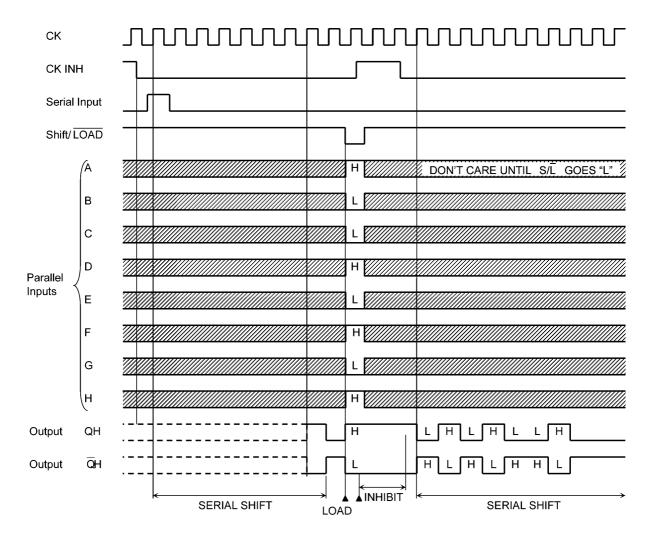
	Inputs					Internal Outputs		puts
SHIFT/ LOAD	CK INH	СК	SERIAL IN	PARALLEL A······H	QA	QB	QH	٩
L	Х	Х	Х	a·····h	а	b	h	h
Н	L		Н	Х	Н	QAn	QGn	QGn
Н	L		L	Х	L	QAn	QGn	QGn
Н		L	Н	Х	Н	QAn	QGn	QG <sub>n</sub>
Н		L	L	Х	L	QAn	QGn	- QGn
Н	Х	Н	Х	Х	No Change			
Н	Н	Х	Х	Х	No Change			

X: Don't care

a.....h: The level of steady state input voltage at inputs A through H respectively.

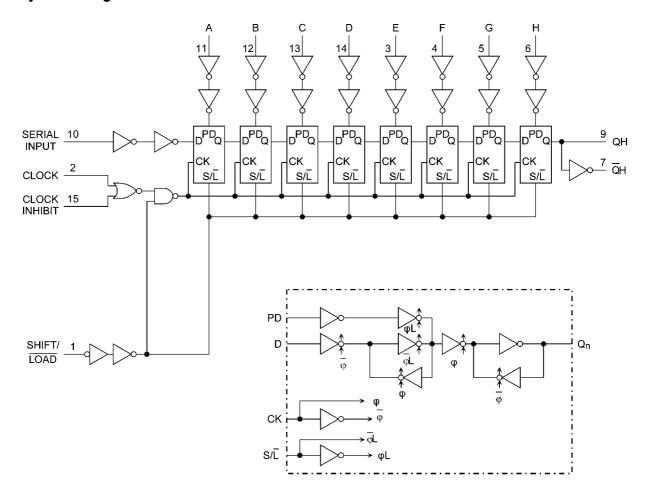
QAn to QGn: The level of QA to QG, respectively, before the most recent positive transition of the CK.

## 9. Timing Diagrams





# 10. System Diagram





## 11. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V <sub>CC</sub>		-0.5 to 7.0	V
Input voltage	V <sub>IN</sub>		-0.5 to V <sub>CC</sub> + 0.5	V
Output voltage	V <sub>OUT</sub>		-0.5 to V <sub>CC</sub> + 0.5	V
Input diode current	I <sub>IK</sub>		±20	mA
Output diode current	lok		±20	mA
Output current	l <sub>out</sub>		±25	mA
V <sub>CC</sub> /ground current	I <sub>CC</sub>		±50	mA
Power dissipation	$P_D$	(Note 1)	500	mW
Storage temperature	T <sub>stg</sub>		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: P<sub>D</sub> derates linearly with -8 mW/°C above 85 °C

## 12. Operating Ranges (Note)

Characteristics	Symbol	Test Condition	Note	Rating	Unit
Supply voltage	V <sub>CC</sub>			2.0 to 6.0	V
Input voltage	V <sub>IN</sub>			0 to V <sub>CC</sub>	V
Output voltage	V <sub>OUT</sub>			0 to V <sub>CC</sub>	V
Operating temperature	T <sub>opr</sub>		(Note 1)	-40 to 125	ů
Input rise and fall times	t <sub>r</sub> ,t <sub>f</sub>	V <sub>CC</sub> = 2.0 V		0 to 1000	ns
		V <sub>CC</sub> = 4.5 V		0 to 500	
		V <sub>CC</sub> = 6.0 V		0 to 400	

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either  $V_{CC}$  or GND.

Note 1: Operating Range spec of  $T_{opr}$  = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.



## 13. Electrical Characteristics

# 13.1. DC Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Test Condition	ı	V <sub>CC</sub> (V)	Min	Тур.	Max	Unit
High-level input voltage	V <sub>IH</sub>	_		2.0	1.50	_	_	V
				4.5	3.15	_	_	
				6.0	4.20			
Low-level input voltage	V <sub>IL</sub>	_		2.0			0.50	V
				4.5		ı	1.35	
				6.0			1.80	
High-level output voltage	V <sub>OH</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$	I <sub>OH</sub> = -20 μA	2.0	1.9	2.0	_	V
				4.5	4.4	4.5	_	
				6.0	5.9	6.0	_	
			I <sub>OH</sub> = -4 mA	4.5	4.18	4.31	_	
			$I_{OH} = -5.2 \text{ mA}$	6.0	5.68	5.80	_	
Low-level output voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 20 μA	2.0		0.0	0.1	V
				4.5	_	0.0	0.1	
				6.0	_	0.0	0.1	
			I <sub>OL</sub> = 4 mA	4.5	_	0.17	0.26	
			I <sub>OL</sub> = 5.2 mA	6.0	_	0.18	0.26	
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		6.0			±0.1	μА
Quiescent supply current	I <sub>CC</sub>	$V_{IN} = V_{CC}$ or GND		6.0	_	_	4.0	μΑ

# 13.2. DC Characteristics (Unless otherwise specified, $T_a$ = -40 to 85 °C)

Characteristics	Symbol	Test Condit	tion	V <sub>CC</sub> (V)	Min	Max	Unit
High-level input voltage	V <sub>IH</sub>	_		2.0	1.50	_	V
				4.5	3.15	_	
				6.0	4.20	_	
Low-level input voltage	V <sub>IL</sub>	_		2.0	_	0.50	V
				4.5	_	1.35	
				6.0	_	1.80	
High-level output voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -20 μA	2.0	1.9	_	V
				4.5	4.4	_	
				6.0	5.9	_	
			$I_{OH} = -4 \text{ mA}$	4.5	4.13	_	
			$I_{OH} = -5.2 \text{ mA}$	6.0	5.63		
Low-level output voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 20 μA	2.0	_	0.1	V
				4.5	_	0.1	
				6.0	_	0.1	
			I <sub>OL</sub> = 4 mA	4.5	_	0.33	
			I <sub>OL</sub> = 5.2 mA	6.0	_	0.33	
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		6.0		±1.0	μА
Quiescent supply current	Icc	V <sub>IN</sub> = V <sub>CC</sub> or GND		6.0		40.0	μА



# 13.3. DC Characteristics (Note) (Unless otherwise specified, T<sub>a</sub> = -40 to 125 °C)

Characteristics	Symbol	Test Cond	dition	V <sub>CC</sub> (V)	Min	Max	Unit
High-level input voltage	V <sub>IH</sub>	_		2.0	1.50	_	V
				4.5	3.15	_	
				6.0	4.20	_	
Low-level input voltage	V <sub>IL</sub>	_		2.0	_	0.50	V
				4.5	_	1.35	
				6.0	_	1.80	
High-level output voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -20 μA	2.0	1.9	_	V
				4.5	4.4	_	
				6.0	5.9	_	
			I <sub>OH</sub> = -4 mA	4.5	3.7	_	
			I <sub>OH</sub> = -5.2 mA	6.0	5.2	_	
Low-level output voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 20 μA	2.0	_	0.1	V
				4.5	_	0.1	
				6.0	_	0.1	
			I <sub>OL</sub> = 4 mA	4.5	_	0.4	
			I <sub>OL</sub> = 5.2 mA	6.0	_	0.4	
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	•	6.0	_	±1.0	μА
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		6.0	_	80.0	μΑ

Note: Operating Range spec of  $T_{opr}$  = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.



# 13.4. Timing Requirements (Unless otherwise specified, $T_a = 25$ °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Limit	Unit
Minimum pulse width	$t_{w(L)}, t_{w(H)}$	_	2.0	75	ns
(CK, CK INH)			4.5	15	
			6.0	13	
Minimum pulse width	t <sub>w(L)</sub>	_	2.0	75	ns
(S/L)			4.5	15	
			6.0	13	
Minimum setup time	t <sub>s</sub>	_	2.0	75	ns
$(PI-S/\overline{L})$			4.5	15	
			6.0	13	
Minimum setup time	ts	_	2.0	75	ns
(SI-CK, CK INH)			4.5	15	1
			6.0	13	1
Minimum setup time	t <sub>s</sub>	_	2.0	75	ns
(S/L-CK, CK INH)			4.5	15	1
			6.0	13	1
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
(PI-S/L)			4.5	0	1
			6.0	0	1
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
(SI-CK, CK INH)			4.5	0	1
			6.0	0	1
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
(S/L-CK, CK INH)			4.5	0	1
			6.0	0	1
Minimum removal time	t <sub>rem</sub>	_	2.0	75	ns
(CK INH-CK), (CK-CK INH)			4.5	15	1
			6.0	13	
Clock frequency	f	_	2.0	7	MHz
			4.5	30	1
			6.0	41	1



# 13.5. Timing Requirements (Unless otherwise specified, $T_a$ = -40 to 85 °C, Input: $t_r$ = $t_f$ = 6 ns)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Limit	Unit
Minimum pulse width	$t_{w(L)},t_{w(H)}$	_	2.0	95	ns
(CK, CK INH)			4.5	19	
			6.0	16	
Minimum pulse width	t <sub>w(L)</sub>	_	2.0	95	ns
(S/L)			4.5	19	
			6.0	16	]
Minimum setup time	t <sub>s</sub>	_	2.0	95	ns
$(PI-S/\overline{L})$			4.5	19	
			6.0	16	]
Minimum setup time	t <sub>s</sub>	_	2.0	95	ns
(SI-CK, CK INH)			4.5	19	
			6.0	16	1
Minimum setup time	t <sub>s</sub>	_	2.0	95	ns
(S/L-CK, CK INH)			4.5	19	
			6.0	16	1
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
$(PI-S/\overline{L})$			4.5	0	
			6.0	0	1
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
(SI-CK, CK INH)			4.5	0	
			6.0	0	1
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
(S/L-CK, CK INH)			4.5	0	
			6.0	0	1
Minimum removal time	t <sub>rem</sub>	_	2.0	95	ns
(CK INH-CK), (CK-CK INH)			4.5	19	1
			6.0	16	1
Clock frequency	f	<del>_</del>	2.0	6	MHz
, ,			4.5	24	1
			6.0	28	1



# 13.6. Timing Requirements (Note) (Unless otherwise specified, $T_a$ = -40 to 125 °C, Input: $t_r$ = $t_f$ = 6 ns)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Limit	Unit
Minimum pulse width	$t_{w(L)}, t_{w(H)}$	_	2.0	110	ns
(CK, CK INH)			4.5	22	
			6.0	18	
Minimum pulse width $(S/\overline{L})$	t <sub>w(L)</sub>	_	2.0	110	ns
			4.5	22	
			6.0	18	
Minimum setup time	t <sub>s</sub>	_	2.0	110	ns
(PI-S/L)			4.5	22	1
			6.0	18	1
Minimum setup time	t <sub>s</sub>	_	2.0	110	ns
(SI-CK, CK INH)			4.5	22	1
			6.0	18	1
Minimum setup time (S/L-CK, CK INH)	t <sub>s</sub>	_	2.0	110	ns
			4.5	22	1
			6.0	18	1
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
$(PI-S/\overline{L})$			4.5	0	1
			6.0	0	1
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
(SI-CK, CK INH)			4.5	0	1
			6.0	0	ĺ
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
(S/L-CK, CK INH)			4.5	0	1
			6.0	0	1
Minimum removal time	t <sub>rem</sub>	_	2.0	110	ns
(CK INH-CK), (CK-CK INH)			4.5	22	
			6.0	18	
Clock frequency	f	_	2.0	5	MHz
,			4.5	20	
			6.0	19	

Note: Operating Range spec of  $T_{opr}$  = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.



# 13.7. AC Characteristics (Unless otherwise specified, $C_L$ = 15 pF, $V_{CC}$ = 5 V, $T_a$ = 25 °C, Input: $t_r$ = $t_f$ = 6 ns)

Characteristics	Symbol	Note	Test Condition	Min	Тур.	Max	Unit
Output transition time	t <sub>TLH</sub> ,t <sub>THL</sub>		_	_	4	8	ns
Propagation delay time (CK, CK INH-QH, QH)	t <sub>PLH</sub> ,t <sub>PHL</sub>		_	_	15	25	ns
Propagation delay time (S/L-QH, QH)	t <sub>PLH</sub> ,t <sub>PHL</sub>		_	_	15	25	ns
Propagation delay time (H-QH, QH)	t <sub>PLH</sub> ,t <sub>PHL</sub>		_	_	14	26	ns
Maximum clock frequency	f <sub>MAX</sub>			35	56	_	MHz

# 13.8. AC Characteristics (Unless otherwise specified, $C_L = 50$ pF, $T_a = 25$ °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Note	Test Condition	V <sub>CC</sub> (V)	Min	Тур.	Max	Unit
Output transition time	t <sub>TLH</sub> ,t <sub>THL</sub>		_	2.0	_	25	75	ns
				4.5	_	8	15	
				6.0	_	7	13	
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>		_	2.0	_	55	150	ns
(CK, CK INH-QH, QH)				4.5	_	18	30	
				6.0	_	15	26	
Propagation delay time (S/L-QH, QH)	t <sub>PLH</sub> ,t <sub>PHL</sub>		_	2.0	_	60	165	ns
				4.5	_	19	33	
				6.0	_	16	28	
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>		_	2.0	_	52	135	ns
(H-QH, QH)				4.5	_	17	27	
				6.0	_	14	23	
Maximum clock frequency	f <sub>MAX</sub>		_	2.0	7	14	_	MHz
				4.5	30	46	_	
				6.0	41	65	_	
Input capacitance	C <sub>IN</sub>		_		_	5	10	pF
Power dissipation capacitance	C <sub>PD</sub>	(Note 1)	_		_	55	_	pF

Note 1:  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.  $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{|N} + I_{CC}$ 



# 13.9. AC Characteristics (Unless otherwise specified, $C_L = 50$ pF, $T_a = -40$ to 85 °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
Output transition time	t <sub>TLH</sub> ,t <sub>THL</sub>	_	2.0	_	95	ns
			4.5	_	19	
			6.0	_	16	
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>	_	2.0	_	190	ns
(CK, CK INH-QH, QH)			4.5	_	38	
			6.0	_	33	
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>	_	2.0	_	205	ns
(S/L-QH, QH)			4.5	_	41	
			6.0	_	35	
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>	_	2.0	_	170	ns
(H-QH, QH)			4.5	_	34	
			6.0	_	29	
Maximum clock frequency	f <sub>MAX</sub>	_	2.0	6	_	MHz
			4.5	24	_	
			6.0	28	_	
Input capacitance	C <sub>IN</sub>	_		_	10	pF

# 13.10. AC Characteristics (Note) (Unless otherwise specified, $C_L = 50$ pF, $T_a = -40$ to 125 °C, Input: $t_r = t_f = 6$ ns)

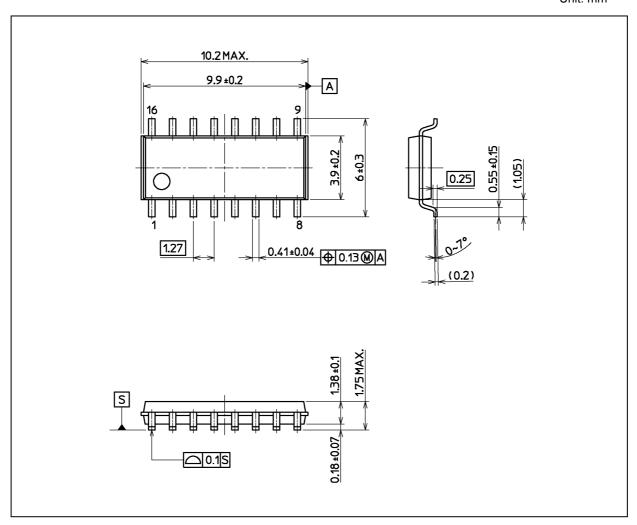
Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
Output transition time	t <sub>TLH</sub> ,t <sub>THL</sub>	_	2.0	_	110	ns
			4.5	_	22	
			6.0	_	18	
Propagation delay time (CK, CK INH-QH, QH)	t <sub>PLH</sub> ,t <sub>PHL</sub>	_	2.0	_	220	ns
			4.5	_	44	
			6.0	_	38	
Propagation delay time (S/L-QH, QH)	t <sub>PLH</sub> ,t <sub>PHL</sub>	_	2.0	_	235	ns
			4.5	_	47	
			6.0	_	40	
Propagation delay time (H-QH, QH)	t <sub>PLH</sub> ,t <sub>PHL</sub>	_	2.0	_	195	ns
			4.5	_	39	
			6.0	_	33	
Maximum clock frequency	f <sub>MAX</sub>	_	2.0	5	_	MHz
			4.5	20	_	
			6.0	19	_	
Input capacitance	C <sub>IN</sub>	_		_	10	pF

Note: Operating Range spec of  $T_{opr}$  = -40 °C to 125 °C is applicable only for the products which manufactured after July 2020.



# **Package Dimensions**

Unit: mm



Weight: 0.15 g (typ.)

	Package Name(s)
Nickname: SOIC16	



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